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Date: April 21, 2008

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Patent No: 6937047 B2 Application No: 10/634484 Applicant: Tu-Anh Tran, et al. Issued: August 30, 2005

Title: INTEGRATED CIRCUIT WITH TEST PAD STRUCTURE AND METHOD OF TESTING

Request for Certificate of Correction:

Consideration has been given to your request for the issuance of a certificate of correction for the above- identified patent under the provisions of Rule 1.322.

Inspection of column 6, line 21, and column 7, line 25 of the application for the above patent reveals that the errors mentioned in your request are in fact printed in accordance with the record in the Patent and Trademark Office, as passed to issue by the examiner. There being no fault on the part of the Patent and Trademark Office, it has no authority to issue a certificate of correction under the provision of 1.322.

In view of the foregoing your request in these matters is hereby denied.

However, further consideration will be given to these matters, upon receipt of a request for certificate of correction under the provision of 1.323, accompanied by the appropriate fee, which is presently \$100.

A certificate of correction will be issued to correct the remaining error mentioned in your request.

Virginia Tolbert

For Mary Diggs, Supervisor Decisions and Certificate of Correction (703) 308-8309 or (703) 308-9390 ext. 113